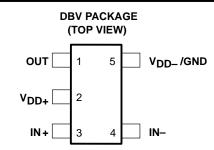
- Output Swing Includes Both Supply Rails
- Low Noise . . . 15 nV/ $\sqrt{\text{Hz}}$ Typ at f = 1 kHz
- Low Input Bias Current . . . 1 pA Typ
- Fully Specified for Single-Supply 3-V and 5-V Operation
- Common-Mode Input Voltage Range Includes Negative Rail
- High Gain Bandwidth . . . 2 MHz at
 V_{DD} = 5 V with 600 Ω Load
- High Slew Rate . . . 1.6 V/μs at V_{DD} = 5 V
- Wide Supply Voltage Range 2.7 V to 10 V
- Macromodel Included



description

The TLV2731 is a single low-voltage operational amplifier available in the SOT-23 package. It offers 2 MHz of bandwidth and 1.6 V/ μ s of slew rate for applications requiring good ac performance. The device exhibits rail-to-rail output performance for increased dynamic range in single or split supply applications. The TLV2731 is fully characterized at 3 V and 5 V and is optimized for low-voltage applications.

The TLV2731, exhibiting high input impedance and low noise, is excellent for small-signal conditioning of high-impedance sources, such as piezoelectric transducers. Because of the micropower dissipation levels combined with 3-V operation, these devices work well in hand-held monitoring and remote-sensing applications. In addition, the rail-to-rail output feature with single- or split-supplies makes this family a great choice when interfacing with analog-to-digital converters (ADCs). The device can also drive $600-\Omega$ loads for telecom applications.

With a total area of 5.6mm², the SOT-23 package only requires one-third the board space of the standard 8-pin SOIC package. This ultra-small package allows designers to place single amplifiers very close to the signal source, minimizing noise pick-up from long PCB traces.

AVAILABLE OPTIONS

т.	Von may AT 25°C	PACKAGED DEVICES SYMBOL		CHIP FORM‡
T _A	V _{IO} max AT 25°C	SOT-23 (DBV)†		(Y)
0°C to 70°C	3 mV	TLV2731CDBV	VALC	TLV2731Y
-40°C to 85°C	3 mV	TLV2731IDBV	VALI	1642/311

[†] The DBV package available in tape and reel only.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

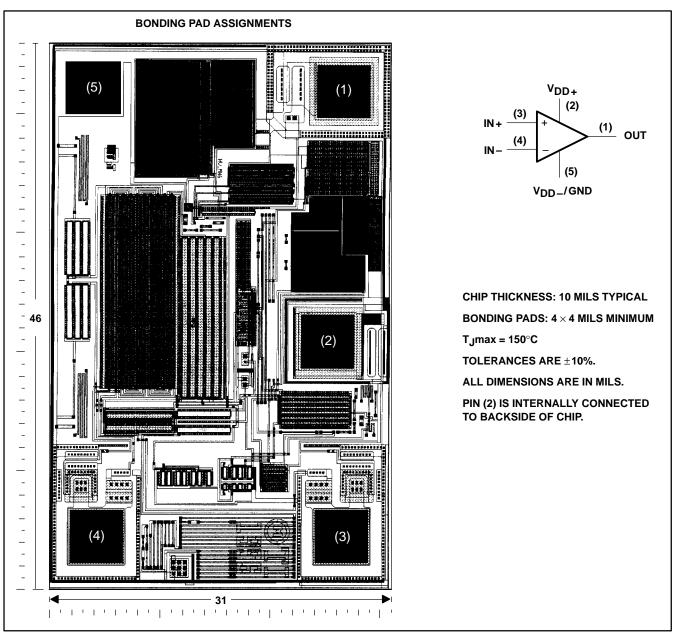
Advanced LinCMOS is a trademark of Texas Instruments.



[‡] Chip forms are tested at T_A = 25°C only.

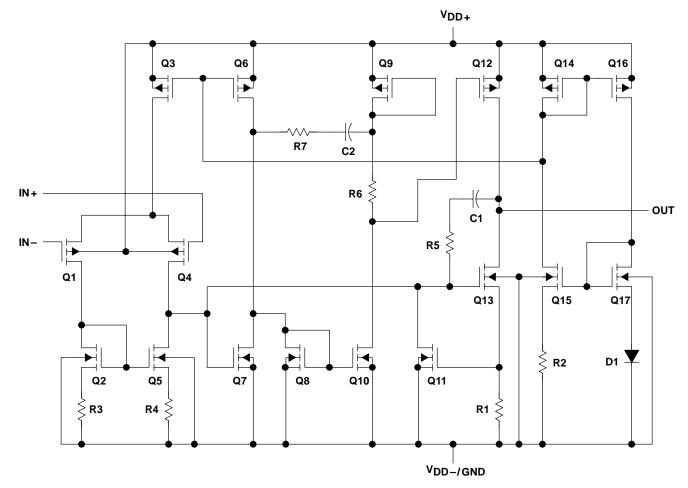
TLV2731Y chip information

This chip, when properly assembled, displays characteristics similar to the TLV2731C. Thermal compression or ultrasonic bonding may be used on the doped-aluminum bonding pads. This chip may be mounted with conductive epoxy or a gold-silicon preform.





equivalent schematic



COMPONENT COUNT [†]					
Transistors	23				
Diodes	5				
Resistors	11				
Capacitors	2				

† Includes both amplifiers and all ESD, bias, and trim circuitry

TLV2731, TLV2731Y Advanced LinCMOS™ RAIL-TO-RAIL LOW-POWER SINGLE OPERATIONAL AMPLIFIERS

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V _{DD} (see Note 1)	12 V
Differential input voltage, V _{ID} (see Note 2)	±V _{DD}
Input voltage range, V _I (any input, see Note 1)	0.3 V to V _{DD}
Input current, I _I (each input)	±5 mA
Output current, I _O	±50 mA
Total current into V _{DD+}	±50 mA
Total current out of V _{DD}	±50 mA
Duration of short-circuit current (at or below) 25°C (see Note 3)	unlimited
Continuous total power dissipation	See Dissipation Rating Table
Operating free-air temperature range, T _A : TLV2731C	0°C to 70°C
TLV2731I	40°C to 85°C
Storage temperature range, T _{stq}	–65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds: DBV package	

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. All voltage values, except differential voltages, are with respect to V_{DD} _.
 - 2. Differential voltages are at the noninverting input with respect to the inverting input. Excessive current flows when input is brought below V_{DD} = 0.3 V.
 - 3. The output may be shorted to either supply. Temperature and/or supply voltages must be limited to ensure that the maximum dissipation rating is not exceeded.

DISSIPATION RATING TABLE

PACKAGE	$T_{\mbox{A}} \le 25^{\circ}\mbox{C}$ POWER RATING	DERATING FACTOR ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING
DBV	150 mW	1.2 mW/°C	96 mW	78 mW

recommended operating conditions

	TL	TLV2731C		TLV2731I		
	MIN	MAX	MIN	MAX	UNIT	
Supply voltage, V _{DD} (see Note 1)	2.7	10	2.7	10	V	
Input voltage range, V _I	V_{DD-}	V _{DD+} -1.3	V _{DD} -	V _{DD+} -1.3	V	
Common-mode input voltage, V _{IC}	V _{DD} _	V _{DD+} -1.3	V _{DD} _	V _{DD+} -1.3	V	
Operating free-air temperature, TA	0	70	-40	85	°C	

NOTE 1: All voltage values, except differential voltages, are with respect to V_{DD} -.



electrical characteristics at specified free-air temperature, $V_{DD} = 3 \text{ V}$ (unless otherwise noted)

	DADAMETED	TEST 001	IDITIONS	- +	TLV2731C		1	ΓLV2731			
	PARAMETER	TEST CON	IDITIONS	T _A †	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
۷ _{IO}	Input offset voltage					0.7	3		0.7	3	mV
αVIO	Temperature coefficient of input offset voltage			Full range		0.5			0.5		μV/°C
	Input offset voltage long-term drift (see Note 4)	$V_{DD\pm} = \pm 1.5 \text{ V},$ $V_{O} = 0,$	$V_{IC} = 0$, RS = 50 Ω	25°C		0.003			0.003		μV/mo
I _{IO}	Input offset current			25°C		0.5	60		0.5	60	pА
10	input onset ourient			Full range			150			150	Ρ/ (
IIB	Input bias current			25°C		1	60		1	60	pА
пр	input blue duriont			Full range			150			150	Ρ, .
VICR	Common-mode input	R _S = 50 Ω,	V _O ≤5 mV	25°C	0 to 2	-0.3 to 2.2		0 to 2	-0.3 to 2.2		V
VICK	voltage range	113 = 00 12,	V O = 0 III V	Full range	0 to 1.7			0 to 1.7			,
	IP ab January and and	$I_{OH} = -1 \text{ mA}$		25°C		2.87			2.87		
Vон	High-level output voltage	Jour 2 mA		25°C		2.74			2.74		V
	vokago	$I_{OH} = -2 \text{ mA}$		Full range	2.3			2.3			
	Landan Landan d	$V_{IC} = 1.5 V$,	$I_{OL} = 50 \mu A$	25°C		10			10		
V_{OL}	Low-level output voltage		voltage $V_{10} = 1.5 \text{ V}$ $I_{01} = 500 \text{ J/A}$	25°C		100			100		mV
		V ₁ C = 1.0 V,	-10L = 000 μ/ι	Full range			300			300	
	Large-signal	V _{IC} = 1.5 V,	$R_1 = 600 \Omega^{\ddagger}$	25°C	1	1.6		1	1.6		
AVD	differential voltage	$V_{O} = 1.5 \text{ V},$ $V_{O} = 1 \text{ V to 2 V}$	_	Full range	0.3			0.3			V/mV
	amplification	Ŭ	$R_L = 1 M\Omega^{\ddagger}$	25°C		250			250		
^r id	Differential input resistance			25°C		10 ¹²			10 ¹²		Ω
r _{ic}	Common-mode input resistance			25°C		10 ¹²			10 ¹²		Ω
c _{ic}	Common-mode input capacitance	f = 10 kHz		25°C		6			6		pF
z _O	Closed-loop output impedance	f = 1 MHz,	A _V = 1	25°C		156			156		Ω
CMRR	Common-mode	V _{IC} = 0 to 1.7 V,		25°C	60	70		60	70		٩D
CIVIKK	rejection ratio	$V_{O} = 1.5 \text{ V},$	$R_S = 50 \Omega$	Full range	55			55			dB
ksvr	Supply voltage rejection ratio	$V_{DD} = 2.7 \text{ V to 8}$ $V_{IC} = V_{DD}/2$,	8 V, No load	25°C	70	96		70	96		dB
	(ΔV _{DD} /ΔV _{IO})	vIC = vDD/2,	INU IUAU	Full range	70			70			
I _{DD}	Supply current	V _O = 1.5 V,	No load	25°C		750	1200		750	1200	μΑ
טט		1.5 v,		Full range			1500			1500	μΑ

[†] Full range for the TLV2731C is 0°C to 70°C. Full range for the TLV2731I is – 40°C to 85°C.



[‡]Referenced to 1.5 V

NOTE 4: Typical values are based on the input offset voltage shift observed through 500 hours of operating life test at $T_A = 150^{\circ}C$ extrapolated to $T_A = 25^{\circ}C$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.

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operating characteristics at specified free-air temperature, V_{DD} = 3 V

	NADAMETED.	TEST SOUR	ITIONS	- +	Т	LV27310	;	1	ΓLV2731		
'	PARAMETER	TEST COND	IIIONS	T _A †	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
	Claus rate at units			25°C	0.75	1.25		0.75	1.25		
SR	Slew rate at unity gain	$V_O = 1.1 \text{ V to } 1.9 \text{ V},$ $C_L = 100 \text{ pF}^{\ddagger}$	$R_L = 600 \Omega^{\ddagger}$,	Full range	0.5			0.5			V/μs
V	Equivalent input	f = 10 Hz		25°C		105			105		nV/√ Hz
Vn	noise voltage	f = 1 kHz		25°C		16			16		nv/√HZ
\/\.\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\	Peak-to-peak equivalent input	f = 0.1 Hz to 1 Hz		25°C		1.4			1.4		μV
V _{N(PP)}	noise voltage	f = 0.1 Hz to 10 Hz		25°C		1.5			1.5		μν
In	Equivalent input noise current			25°C		0.6			0.6		fA/√ Hz
		$V_O = 1 \text{ V to 2 V},$ f = 20 kHz.	A _V = 1	25°C		0.285%			0.285%		
	Total harmonic distortion plus noise	$R_L = 600 \Omega^{\ddagger}$	A _V = 10	25.0		7.2%			7.2%		
THD+N		V _O = 1 V to 2 V,	A _V = 1			0.014%			0.014%		
	Tioise	f = 20 kHz,	A _V = 10	25°C		0.098%			0.098%		
		R _L = 600 Ω§	$A_{V} = 100$			0.13%			0.13%		
	Gain-bandwidth product	f = 10 kHz, $C_L = 100 \text{ pF}^{\ddagger}$	$R_L = 600 \Omega^{\ddagger}$,	25°C		1.9			1.9		MHz
ВОМ	Maximum output- swing bandwidth	$V_{O(PP)} = 1 \text{ V},$ $R_{L} = 600 \Omega^{\ddagger},$	$A_V = 1,$ $C_L = 100 \text{ pF}^{\ddagger}$	25°C		60			60		kHz
	Settling time	$A_V = -1$, Step = 1 V to 2 V,	To 0.1%	25°C		0.9			0.9		μs
t _S	Octaing time	$R_L = 600 \Omega^{\ddagger},$ $C_L = 100 pF^{\ddagger}$	To 0.01%	25 0		1.5			1.5		μο
φm	Phase margin at unity gain	R _L = 600 Ω [‡] ,	C _L = 100 pF‡	25°C		50°			50°		
	Gain margin] -		25°C		8			8		dB
				_							

[†]Full range is -40°C to 85°C.



[‡]Referenced to 1.5 V

[§] Referenced to 0 V

electrical characteristics at specified free-air temperature, $V_{\mbox{\scriptsize DD}}$ = 5 V (unless otherwise noted)

	PARAMETER	TEST CON	IDITIONS	T. †	TLV2731C		٦	TLV2731	I	LINUT	
	PARAMETER	TEST CON	IDITIONS	T _A †	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
VIO	Input offset voltage					0.7	3		0.7	3	mV
αΛΙΟ	Temperature coefficient of input offset voltage			Full range		0.5			0.5		μV/°C
	Input offset voltage long-term drift (see Note 4)	$V_{DD\pm} = \pm 2.5 \text{ V},$ $V_{O} = 0,$	$V_{IC} = 0$, R _S = 50 Ω	25°C		0.003			0.003		μV/mo
IIO	Input offset current			25°C		0.5	60		0.5	60	pА
10	input onset current			Full range			150			150	- ΡΑ
I _{IB}	Input bias current			25°C		1	60		1	60	pА
'ID	mpar sido carroni			Full range			150			150	Ρ, ,
VICR	Common-mode input	$R_S = 50 \Omega$,	V O ≤5 mV	25°C	0 to 4	-0.3 to 4.2		0 to 4	-0.3 to 4.2		V
TICK	voltage range		14101 = 3 4	Full range	0 to 3.7			0 to 3.7			•
	High lavel autout	$I_{OH} = -1 \text{ mA}$		25°C		4.9			4.9		
۷он	High-level output voltage	I _{OH} = -4 mA		25°C		4.6			4.6		V
	- Tollago	IOH = -4 IIIA		Full range	4.3			4.3			
	Lave lavel autout	$V_{IC} = 2.5 V$,	I _{OL} = 500 μA	25°C		80			80		
VOL	Low-level output voltage $V_{IC} = 2.5 \text{ V}, I_{OL} = 1$	I _{OL} = 1 mA	25°C		160			160		mV	
		VIC = 2.0 V,		Full range			500			500	
	Large-signal	V _{IC} = 2.5 V,	$R_{L} = 600 \Omega^{\ddagger}$	25°C	1	1.5		1	1.5		
AVD	differential voltage	$V_0 = 1 \text{ V to 4 V}$		Full range	0.3			0.3			V/mV
	amplification		$R_L = 1 M\Omega^{\ddagger}$	25°C		400			400		
^r id	Differential input resistance			25°C		10 ¹²			10 ¹²		Ω
r _{ic}	Common-mode input resistance			25°C		10 ¹²			10 ¹²		Ω
c _{ic}	Common-mode input capacitance	f = 10 kHz		25°C		6			6		pF
z _o	Closed-loop output impedance	f = 1 MHz,	A _V = 1	25°C		138			138		Ω
CMRR	Common-mode	$V_{IC} = 0 \text{ to } 2.7 \text{ V},$		25°C	60	70		60	70		dB
CIVIER	rejection ratio	$V_0 = 2.5 \text{ V},$	$R_S = 50 \Omega$	Full range	55			55			ub
ksvr	Supply voltage rejection ratio	$V_{DD} = 4.4 \text{ V to 8}$ $V_{IC} = V_{DD}/2$,	3 V, No load	25°C	70	96		70	96		dB
	(ΔV _{DD} /ΔV _{IO})	*IC = *DD/2,	140 1000	Full range	70			70			
I _{DD}	Supply current	V _O = 2.5 V,	No load	25°C		850	1300		850	1300	μΑ
טט	11.7		-	Full range			1600			1600	F-11-

[†] Full range for the TLV2731C is 0°C to 70°C. Full range for the TLV2731I is – 40°C to 85°C.

NOTE 5: Typical values are based on the input offset voltage shift observed through 500 hours of operating life test at $T_A = 150$ °C extrapolated to $T_A = 25$ °C using the Arrhenius equation and assuming an activation energy of 0.96 eV.



[‡]Referenced to 2.5 V

TLV2731, TLV2731Y Advanced LinCMOS™ RAIL-TO-RAIL LOW-POWER SINGLE OPERATIONAL AMPLIFIERS SLOS198A – AUGUST 1997 – REVISED MARCH 2001

operating characteristics at specified free-air temperature, V_{DD} = 5 V

$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	MAX V/μs	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	V/µs	MAX
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	V/μs	
Vn Equivalent input noise voltage f = 1 kHz 25°C 15 15 Peak-to-peak f = 0.1 Hz to 1 Hz 25°C 1.4 1.4		
Peak-to-peak	nV/√H	
1	IIV/ \I	
VN(PP) equivalent input	μV	
noise voltage	μν	
In Equivalent input noise current 25°C 0.6 0.6	fA/√H:	
V _O = 1.5 V to 3.5 V, A _V = 1 0.409% 0.409% f = 20 kHz.		
Total harmonic $R_L = 600 \Omega^{\ddagger}$ $A_V = 10$ 3.68% 3.68%		
THD+N distortion plus noise $V_O = 1.5 \text{ V to } 3.5 \text{ V}, A_V = 1 \qquad \qquad 0.018\% \qquad \qquad 0.018\%$		
$f = 20 \text{ kHz}, \qquad A_V = 10 \qquad 25^{\circ}\text{C} \qquad 0.045\% \qquad 0.045\%$		
$R_L = 600 \Omega$ $A_V = 100$ 0.116% 0.116%		
	MHz	
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	kHz	
$A_V = -1$, $S_{tep} = 1.5 \text{ V to } 3.5 \text{ V}$	μs	
ts Settling time $R_L = 600 \Omega^{\ddagger}$, $C_L = 100 \text{ pF}^{\ddagger}$ To 0.01% 25°C 2.4 2.4	μς	
Phase margin at unity gain $R_L = 600 \Omega^{\ddagger}$, $C_L = 100 \text{ pF}^{\ddagger}$ 25°C 48° 48°		
Gain margin 25°C 8 8	dB	

[†] Full range is –40°C to 85°C.



[‡]Referenced to 2.5 V

[§] Referenced to 0 V

electrical characteristics at V_{DD} = 3 V, T_A = 25°C (unless otherwise noted)

PARAMETER		TEST C	ONDITIONS	TI	TLV2731Y		
	PARAMETER	TEST	ONDITIONS	MIN	TYP	MAX	UNIT
ViO	Input offset voltage				750		μV
lιO	Input offset current	$V_{DD} \pm = \pm 1.5 \text{ V},$ $R_S = 50 \Omega$	VIC = 0, VO = 0,		0.5	60	pА
I _{IB}	Input bias current	115 = 30 22			1	60	pΑ
VICR	Common-mode input voltage range	V _{IO} ≤5 mV,	$R_S = 50 \Omega$		-0.3 to 2.2		V
Vон	High-level output voltage	I _{OH} = -1 mA			2.87		V
V	Low lovel output voltage	V _{IC} = 1.5 V,	I _{OL} = 50 μA		10		mV
VOL	Low-level output voltage	V _{IC} = 1.5 V,	I _{OL} = 500 μA		100		IIIV
Δ	l anno airean differential coltano annulification	\/- 4\/+= 0\/	$R_L = 600 \Omega^{\dagger}$		1.6		\//\/
AVD	Large-signal differential voltage amplification	$V_0 = 1 \text{ V to } 2 \text{ V}$	$R_L = 1 M\Omega^{\dagger}$		250		V/mV
r _{id}	Differential input resistance				1012		Ω
r _{ic}	Common-mode input resistance				1012		Ω
c _{ic}	Common-mode input capacitance	f = 10 kHz			6		pF
z _O	Closed-loop output impedance	f = 1 MHz,	A _V = 1		156		Ω
CMRR	Common-mode rejection ratio	$V_{IC} = 0 \text{ to } 1.7 \text{ V},$	$V_0 = 0$, $R_S = 50 \Omega$		70		dB
kSVR	Supply voltage rejection ratio ($\Delta V_{DD}/\Delta V_{IO}$)	$V_{DD} = 2.7 \text{ V to 8 V},$	V _{IC} = 0, No load		96		dB
I _{DD}	Supply current	V _O = 0,	No load		750		μΑ

[†] Referenced to 1.5 V

electrical characteristics at V_{DD} = 5 V, T_A = 25°C (unless otherwise noted)

	PARAMETER	TEST C	ONDITIONS	TLV2731Y			
	PARAMETER	l lesi c	UNDITIONS	MIN	TYP	MAX	UNIT
VIO	Input offset voltage	.,			710		μV
IIO	Input offset current	$V_{DD} \pm = \pm 1.5 \text{ V},$ $R_S = 50 \Omega$	$V_{IC} = 0, V_{O} = 0,$		0.5	60	pА
I _{IB}	Input bias current	11.5 - 00 12			1	60	pА
VICR	Common-mode input voltage range	V _{IO} ≤5 mV,	R _S = 50 Ω		-0.3 to 4.2		٧
Vон	High-level output voltage	$I_{OH} = -1 \text{ mA}$			4.9		V
\/ a.	Law lavel autout valtage	V _{IC} = 2.5 V,	I _{OL} = 500 μA		80		mV
VOL	Low-level output voltage	V _{IC} = 2.5 V,	I _{OL} = 1 mA		160		IIIV
Δ	Lorgo pignol differential valte as appolitication	V- 1 V to 2 V	$R_L = 600 \Omega^{\dagger}$		15		V/mV
AVD	Large-signal differential voltage amplification	$V_O = 1 \text{ V to 2 V}$ $R_L = 1 \text{ M}\Omega^{\dagger}$ 4		400		V/IIIV	
r _{id}	Differential input resistance				1012		Ω
r _{ic}	Common-mode input resistance				1012		Ω
cic	Common-mode input capacitance	f = 10 kHz			6		pF
z _O	Closed-loop output impedance	f = 1 MHz,	A _V = 1		138		Ω
CMRR	Common-mode rejection ratio	$V_{IC} = 0 \text{ to } 1.7 \text{ V},$	$V_{O} = 0$, $R_{S} = 50 \Omega$		70		dB
ksvr	Supply voltage rejection ratio ($\Delta V_{DD}/\Delta V_{IO}$)	$V_{DD} = 2.7 \text{ V to 8 V},$	V _{IC} = 0, No load		96	·	dB
I _{DD}	Supply current	V _O = 0,	No load		850		μΑ

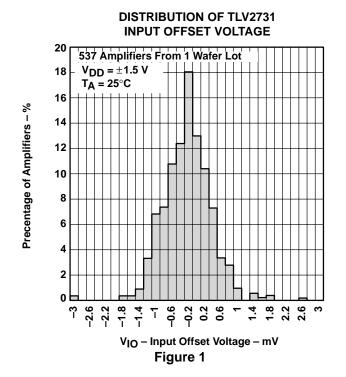
[†] Referenced to 2.5 V

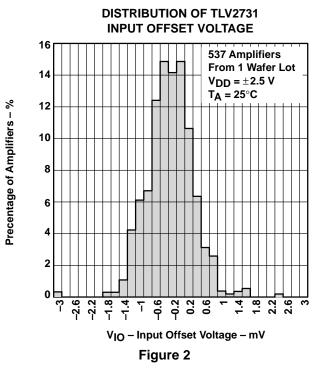


Table of Graphs

			FIGURE
VIO	Input offset voltage	Distribution vs Common-mode input voltage	1, 2 3, 4
αVIO	Input offset voltage temperature coefficient	Distribution	5, 6
I _{IB} /I _{IO}	Input bias and input offset currents	vs Free-air temperature	7
VI	Input voltage	vs Supply voltage vs Free-air temperature	8 9
Vон	High-level output voltage	vs High-level output current	10, 13
VOL	Low-level output voltage	vs Low-level output current	11, 12, 14
V _{O(PP)}	Maximum peak-to-peak output voltage	vs Frequency	15
IOS	Short-circuit output current	vs Supply voltage vs Free-air temperature	16 17
VO	Output voltage	vs Differential input voltage	18, 19
AVD	Differential voltage amplification	vs Load resistance	20
AVD	Large-signal differential voltage amplification	vs Frequency vs Free-air temperature	21, 22 23, 24
z _o	Output impedance	vs Frequency	25, 26
CMRR	Common-mode rejection ratio	vs Frequency vs Free-air temperature	27 28
ksvr	Supply-voltage rejection ratio	vs Frequency vs Free-air temperature	29, 30 31
I _{DD}	Supply current	vs Supply voltage	32
SR	Slew rate	vs Load capacitance vs Free-air temperature	33 34
٧o	Inverting large-signal pulse response		35, 36
٧o	Voltage-follower large-signal pulse response		37, 38
٧o	Inverting small-signal pulse response		39, 40
٧o	Voltage-follower small-signal pulse response		41, 42
V _n	Equivalent input noise voltage	vs Frequency	43, 44
	Noise voltage (referred to input)	Over a 10-second period	45
THD + N	Total harmonic distortion plus noise	vs Frequency	46
	Gain-bandwidth product	vs Free-air temperature vs Supply voltage	47 48
	Gain margin	vs Load capacitance	49, 50
фm	Phase margin	vs Frequency vs Load capacitance	21, 22 51, 52
B ₁	Unity-gain bandwidth	vs Load capacitance	53, 54





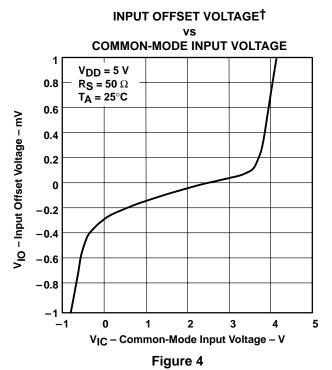


V_{IC} – Common-Mode Input Voltage – V Figure 3

-0.8

-1

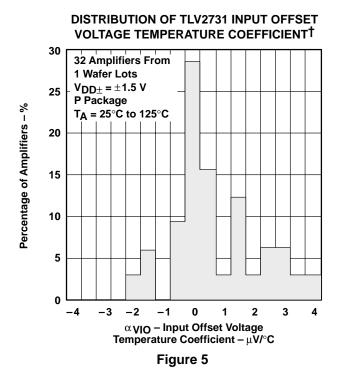
INPUT OFFSET VOLTAGE[†]



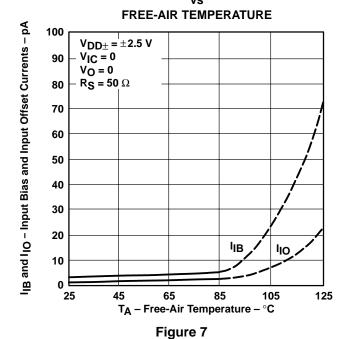
† For all curves where $V_{DD} = 5 \text{ V}$, all loads are referenced to 2.5 V. For all curves where $V_{DD} = 3 \text{ V}$, all loads are referenced to 1.5 V.



TYPICAL CHARACTERISTICS



INPUT BIAS AND INPUT OFFSET CURRENTS†



DISTRIBUTION OF TLV2731 INPUT OFFSET VOLTAGE TEMPERATURE COEFFICIENT[†]

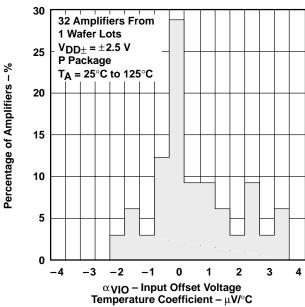
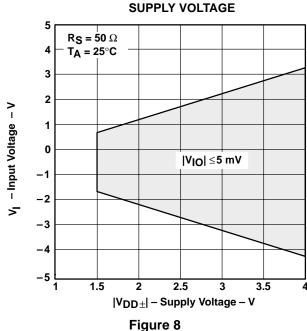


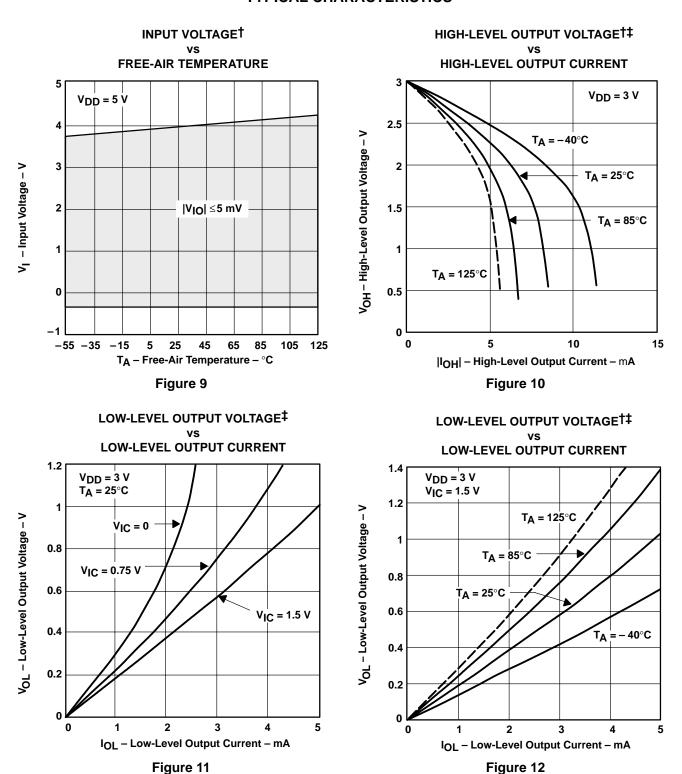
Figure 6

INPUT VOLTAGE vs



[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



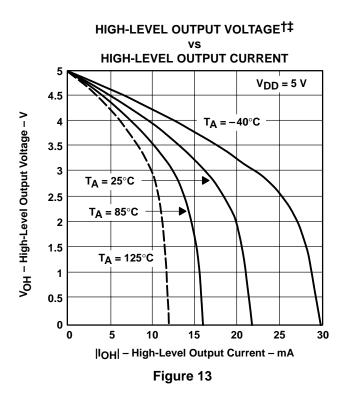


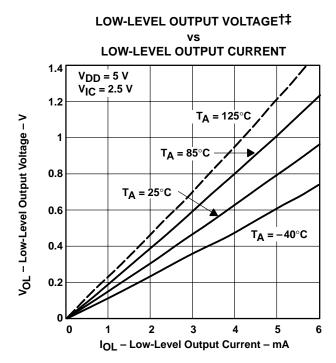
[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

[‡] For all curves where V_{DD} = 5 V, all loads are referenced to 2.5 V. For all curves where V_{DD} = 3 V, all loads are referenced to 1.5 V.

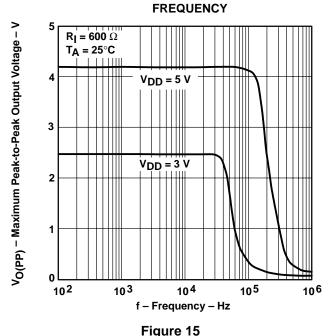


TYPICAL CHARACTERISTICS



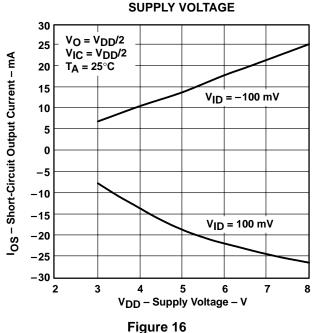


MAXIMUM PEAK-TO-PEAK OUTPUT VOLTAGE[‡]



SHORT-CIRCUIT OUTPUT CURRENT vs SUPPLY VOLTAGE

Figure 14

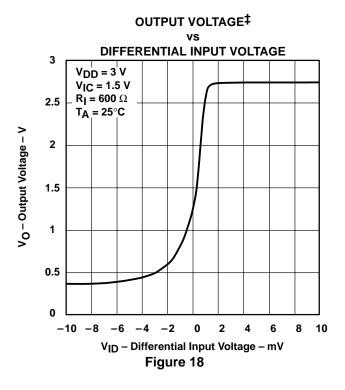


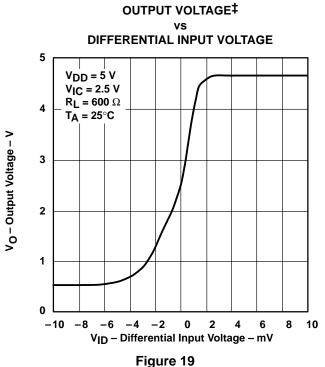
[†]Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

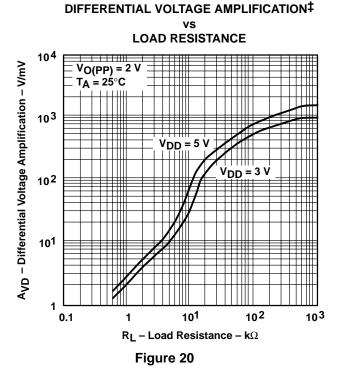
[‡] For all curves where V_{DD} = 5 V, all loads are referenced to 2.5 V. For all curves where V_{DD} = 3 V, all loads are referenced to 1.5 V.



SHORT-CIRCUIT OUTPUT CURRENT †‡ FREE-AIR TEMPERATURE 30 $V_{DD} = 5 V$ 25 $V_{IC} = 2.5 V$ IOS - Short-Circuit Output Current - mA V_O = 2.5 V 20 15 $V_{ID} = -100 \text{ mV}$ 10 5 0 -5 -10V_{ID} = 100 mV -15 -20 -25 -30-5025 50 75 100 125 -75 -250 TA - Free-Air Temperature - °C Figure 17







[†]Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

[‡] For all curves where $V_{DD} = 5$ V, all loads are referenced to 2.5 V. For all curves where $V_{DD} = 3$ V, all loads are referenced to 1.5 V.



LARGE-SIGNAL DIFFERENTIAL VOLTAGE AMPLIFICATION AND PHASE MARGIN[†]

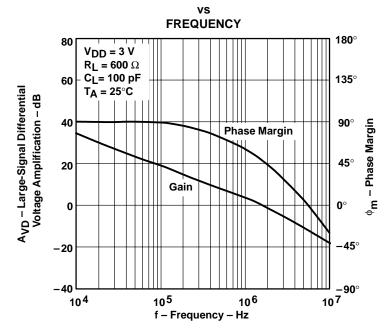
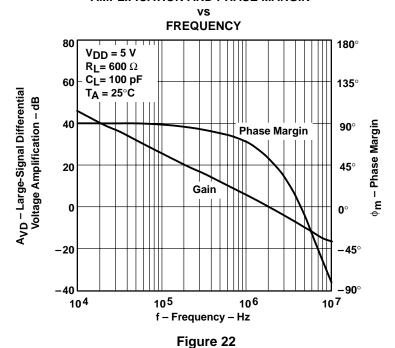


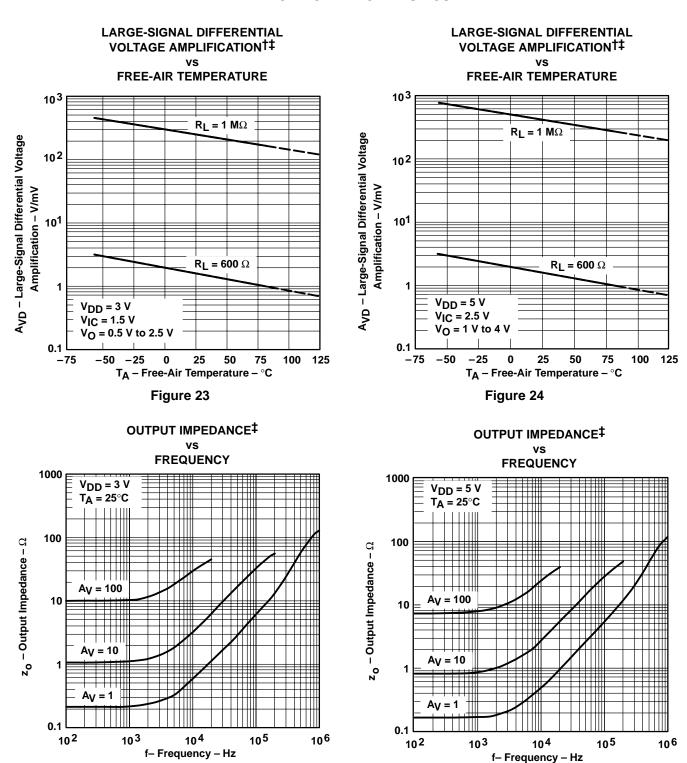
Figure 21

LARGE-SIGNAL DIFFERENTIAL VOLTAGE AMPLIFICATION AND PHASE MARGIN[†]



† For all curves where $V_{DD} = 5 \text{ V}$, all loads are referenced to 2.5 V. For all curves where $V_{DD} = 3 \text{ V}$, all loads are referenced to 1.5 V.





[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

Figure 25

[‡] For all curves where V_{DD} = 5 V, all loads are referenced to 2.5 V. For all curves where V_{DD} = 3 V, all loads are referenced to 1.5 V.



Figure 26

COMMON-MODE REJECTION RATIO† vs **FREQUENCY** 100 $T_A = 25^{\circ}C$ CMRR - Common-Mode Rejection Ratio - dB $V_{DD} = 5 V$ $V_{IC} = 2.5 V$ 80 $V_{DD} = 3 V$ 60 $V_{IC} = 1.5 V$ 40 20 105 106 102 104 103 107 f - Frequency - Hz

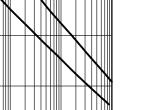
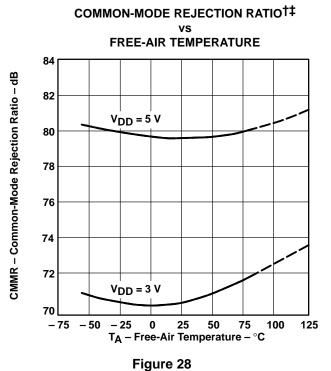
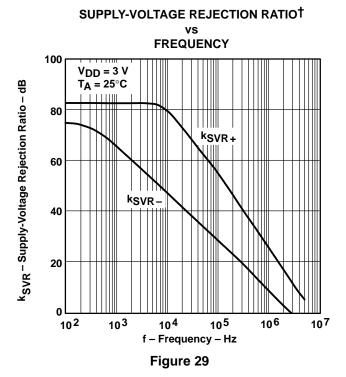
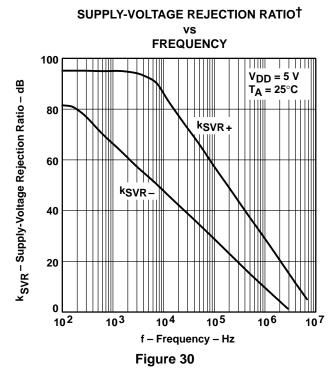


Figure 27









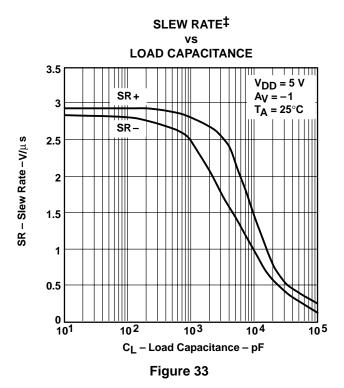
[†] For all curves where V_{DD} = 5 V, all loads are referenced to 2.5 V. For all curves where V_{DD} = 3 V, all loads are referenced to 1.5 V.

[‡] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



SUPPLY-VOLTAGE REJECTION RATIO[†] FREE-AIR TEMPERATURE 100 V_{DD} = 2.7 V to 8 V k_{SVR} - Supply-Voltage Rejection Ratio - dB $V_{IC} = V_O = V_{DD}/2$ 98 96 94 92 _75 -50 25 50 75 100 125 T_A – Free-Air Temperature – $^{\circ}C$

Figure 31



SUPPLY CURRENT[†] vs SUPPLY VOLTAGE

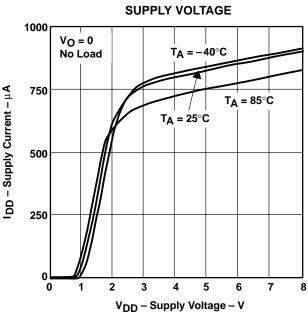


Figure 32

SLEW RATE†‡ vs FREE-AIR TEMPERATURE

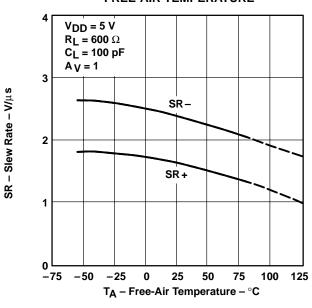


Figure 34

[‡] For all curves where $V_{DD} = 5$ V, all loads are referenced to 2.5 V. For all curves where $V_{DD} = 3$ V, all loads are referenced to 1.5 V.



[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

3

0.5 1 1.5

TYPICAL CHARACTERISTICS

INVERTING LARGE-SIGNAL PULSE RESPONSE† $V_{DD} = 3 V$ $R_L = 600 \Omega$

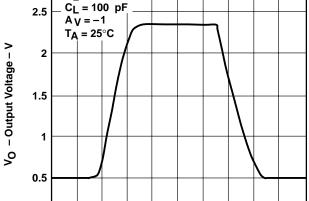


Figure 35

2 2.5 3 3.5

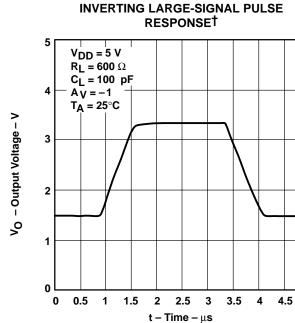


Figure 36



 $t - Time - \mu s$

4.5

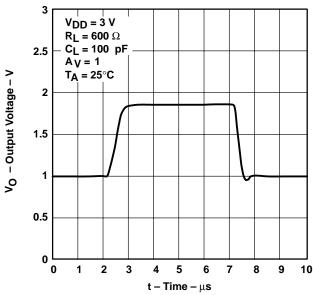


Figure 37

VOLTAGE-FOLLOWER LARGE-SIGNAL PULSE RESPONSE[†]

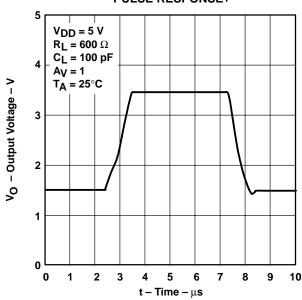


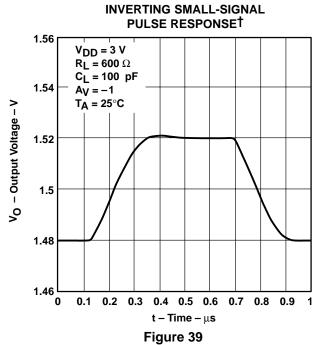
Figure 38

† For all curves where V_{DD} = 5 V, all loads are referenced to 2.5 V. For all curves where V_{DD} = 3 V, all loads are referenced to 1.5 V.



2.46

0 0.1



VOLTAGE-FOLLOWER SMALL-SIGNAL

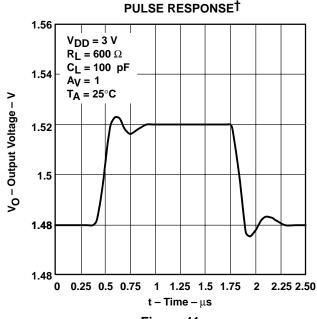


Figure 41

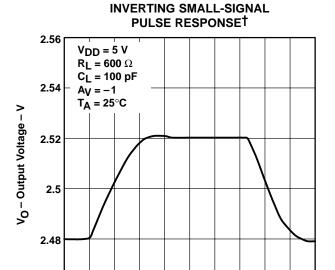


Figure 40

VOLTAGE-FOLLOWER SMALL-SIGNAL PULSE RESPONSE[†]

0.2 0.3 0.4 0.5 0.6 0.7 0.8 0.9

t - Time - μs

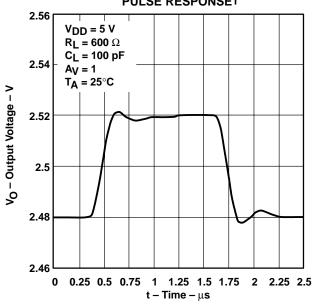
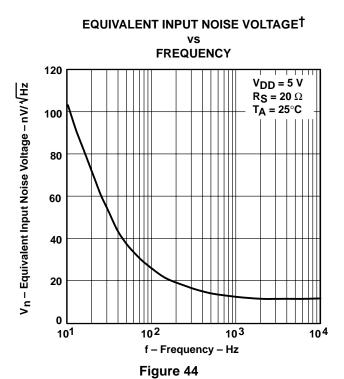


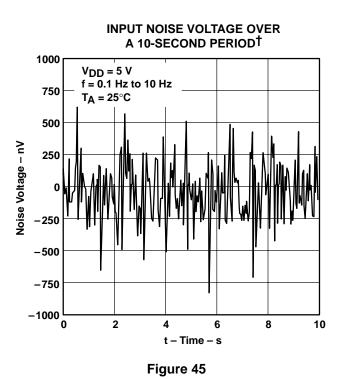
Figure 42

 \dagger For all curves where V_{DD} = 5 V, all loads are referenced to 2.5 V. For all curves where V_{DD} = 3 V, all loads are referenced to 1.5 V.



EQUIVALENT INPUT NOISE VOLTAGE[†] vs **FREQUENCY** 120 $V_{DD} = 3 V$ V_{n} – Equivalent Input Noise Voltage – nV/ $\sqrt{\text{Hz}}$ $R_S = 20 \Omega$ T_A = 25°C 100 80 60 40 20 0 101 10² 103 104 f - Frequency - Hz Figure 43





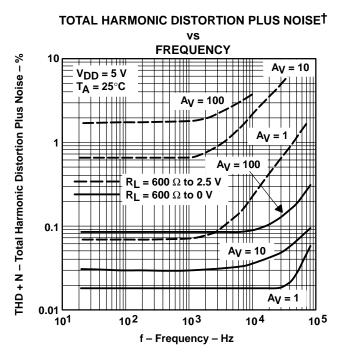
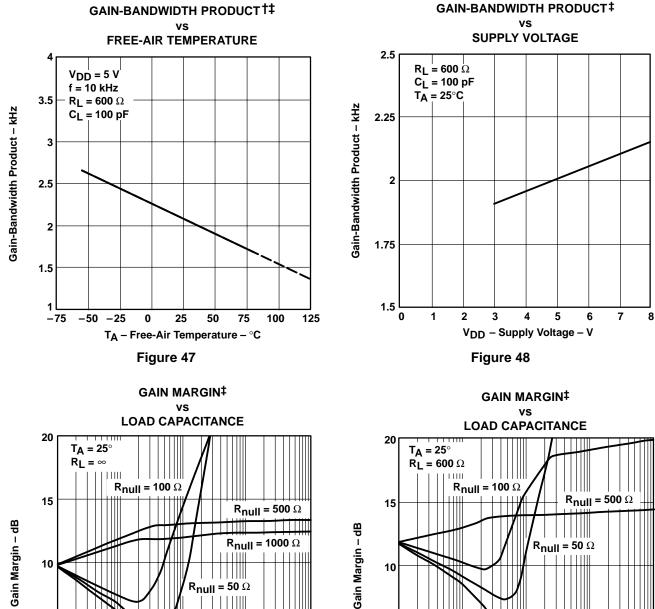


Figure 46

† For all curves where $V_{DD} = 5 \text{ V}$, all loads are referenced to 2.5 V. For all curves where $V_{DD} = 3 \text{ V}$, all loads are referenced to 1.5 V.





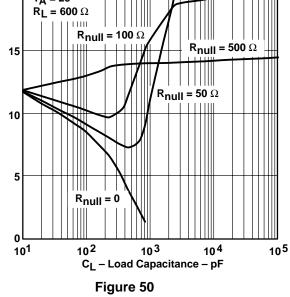
102 103 104 105 C_L - Load Capacitance - pF Figure 49

5

0

101

 $R_{null} = 0$



[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

[‡] For all curves where V_{DD} = 5 V, all loads are referenced to 2.5 V. For all curves where V_{DD} = 3 V, all loads are referenced to 1.5 V.



TYPICAL CHARACTERISTICS

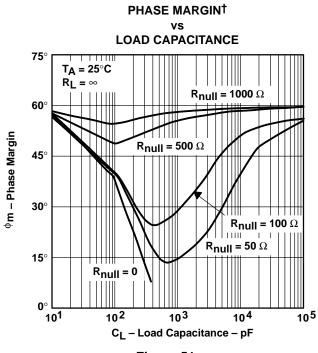


Figure 51

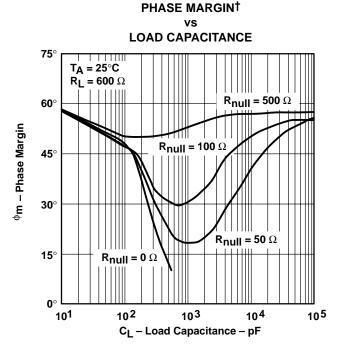
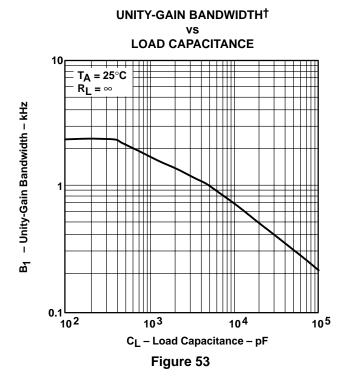
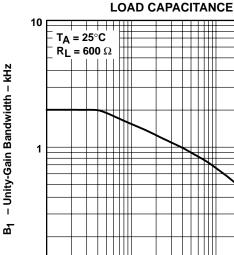


Figure 52

UNITY-GAIN BANDWIDTH†
vs





0.1 10² 10³ 10⁴ C_L – Load Capacitance – pF Figure 54

105

† For all curves where $V_{DD} = 5 \text{ V}$, all loads are referenced to 2.5 V. For all curves where $V_{DD} = 3 \text{ V}$, all loads are referenced to 1.5 V.



APPLICATION INFORMATION

driving large capacitive loads

The TLV2731 is designed to drive larger capacitive loads than most CMOS operational amplifiers. Figure 49 through Figure 54 illustrate its ability to drive loads greater than 100 pF while maintaining good gain and phase margins (R_{null} = 0).

A small series resistor (R_{null}) at the output of the device (see Figure 55) improves the gain and phase margins when driving large capacitive loads. Figure 49 through Figure 52 show the effects of adding series resistances of 50 Ω , 100 Ω , 500 Ω , and 1000 Ω . The addition of this series resistor has two effects: the first effect is that it adds a zero to the transfer function and the second effect is that it reduces the frequency of the pole associated with the output load in the transfer function.

The zero introduced to the transfer function is equal to the series resistance times the load capacitance. To calculate the approximate improvement in phase margin, equation 1 can be used.

$$\Delta \phi_{m1} = \tan^{-1} \left(2 \times \pi \times \text{UGBW} \times R_{null} \times C_{L} \right)$$
Where :

 $\Delta \phi_{m1}$ = Improvement in phase margin

UGBW = Unity-gain bandwidth frequency

R_{null} = Output series resistance

 C_1 = Load capacitance

The unity-gain bandwidth (UGBW) frequency decreases as the capacitive load increases (see Figure 53 and Figure 54). To use equation 1, UGBW must be approximated from Figure 53 and Figure 54.

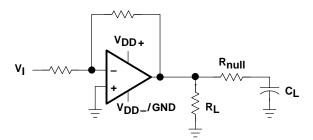


Figure 55. Series-Resistance Circuit

APPLICATION INFORMATION

macromodel information

Macromodel information provided was derived using Microsim $Parts^{TM}$, the model generation software used with Microsim $PSpice^{TM}$. The Boyle macromodel (see Note 6) and subcircuit in Figure 56 are generated using the TLV2731 typical electrical and operating characteristics at $T_A = 25$ °C. Using this information, output simulations of the following key parameters can be generated to a tolerance of 20% (in most cases):

- Maximum positive output voltage swing
- Maximum negative output voltage swing
- Slew rate
- Quiescent power dissipation
- Input bias current
- Open-loop voltage amplification

- Unity-gain frequency
- Common-mode rejection ratio
- Phase margin
- DC output resistance
- AC output resistance
- Short-circuit output current limit

NOTE 6: G. R. Boyle, B. M. Cohn, D. O. Pederson, and J. E. Solomon, "Macromodeling of Integrated Circuit Operational Amplifiers," *IEEE Journal of Solid-State Circuits*, SC-9, 353 (1974).

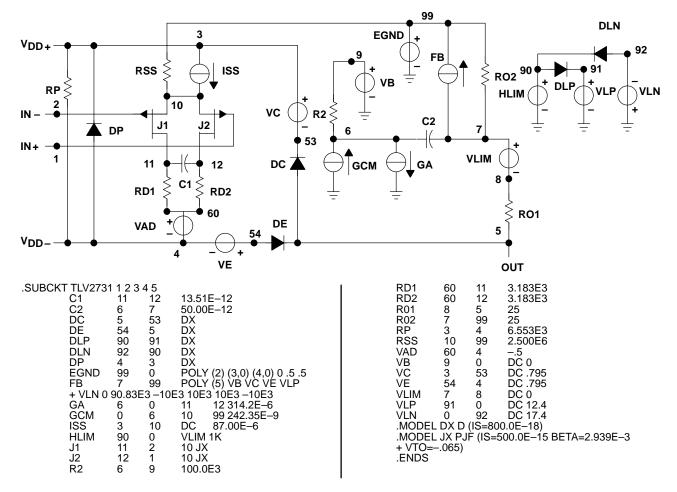


Figure 56. Boyle Macromodel and Subcircuit

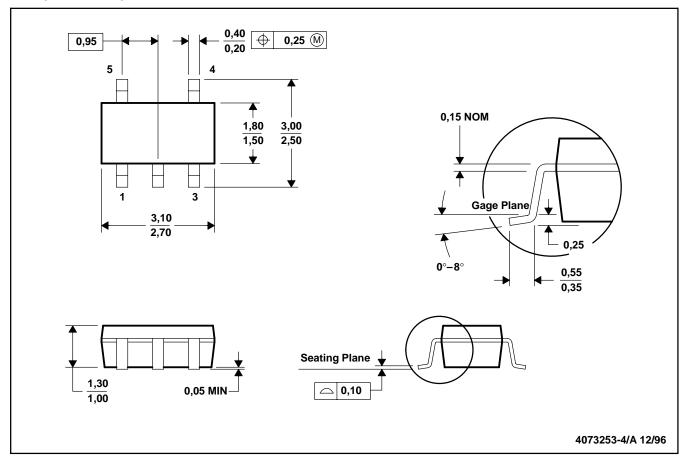
PSpice and Parts are trademark of MicroSim Corporation.



MECHANICAL INFORMATION

DBV (R-PDSO-G5)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions include mold flash or protrusion.

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PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
TLV2731CDBVR	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	VALC	Samples
TLV2731CDBVT	ACTIVE	SOT-23	DBV	5	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM		VALC	Samples
TLV2731IDBVR	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	VALI	Samples
TLV2731IDBVT	ACTIVE	SOT-23	DBV	5	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM		VALI	Samples
TLV2731IDBVTG4	ACTIVE	SOT-23	DBV	5	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM		VALI	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.



PACKAGE OPTION ADDENDUM

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TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TLV2731CDBVR	SOT-23	DBV	5	3000	180.0	9.0	3.15	3.2	1.4	4.0	8.0	Q3
TLV2731CDBVT	SOT-23	DBV	5	250	180.0	9.0	3.15	3.2	1.4	4.0	8.0	Q3
TLV2731IDBVR	SOT-23	DBV	5	3000	180.0	9.0	3.15	3.2	1.4	4.0	8.0	Q3
TLV2731IDBVT	SOT-23	DBV	5	250	180.0	9.0	3.15	3.2	1.4	4.0	8.0	Q3





*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TLV2731CDBVR	SOT-23	DBV	5	3000	182.0	182.0	20.0
TLV2731CDBVT	SOT-23	DBV	5	250	182.0	182.0	20.0
TLV2731IDBVR	SOT-23	DBV	5	3000	182.0	182.0	20.0
TLV2731IDBVT	SOT-23	DBV	5	250	182.0	182.0	20.0

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